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036140/US - 475387-00020 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventor(s)

Guillermo J. Tearney et al.

Serial No.

: 10/765,430

Filed

January 26, 2004

Entitled

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LOW-COHERENCE INTERFEROMETRY

SYSTEM AND METHOD FOR IDENTIFYING TISSUE USING

Group Art Unit

3737

Examiner

To be assigned

INFORMATION DISCLOSURE STATEMENT

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Pursuant to 37 C.F.R. §§ 1.56 and 1.97(b), applicants bring to the attention of the Examiner the documents listed on the attached Form PTO 1449, and respectfully request that the listed documents be considered by the Examiner and made of record in the above-captioned application. Copies of the United States patent references listed on the Form PTO-1449 are not enclosed, but the PCT, foreign and non-patent references are enclosed.

This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that the listed documents are material or constitute "prior art." If the Examiner applies the documents as prior art against any claim in the application and applicants determine that the cited documents do not constitute "prior art" under

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United States law, applicants reserve the right to present to the Office the relevant facts and law

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Applicants further reserve the right to take appropriate action to establish the

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This submission is being filed before any action by the U.S. Patent and

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Respectfully submitted,

DORSEY & WHITNEY, LLP

Gary Abelev

PTO Reg. No. 40,479

Attorneys for Applicants

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PTO/SB/21 (02-04) Approved for use through 07/31/2006. OMB 0651-0031 U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE are required to respond to a collection of information unless it displays a valid OMB control number. **Application Number** 10/765.430 **TRANSMITTAL** Filing Date January 26, 2004 **FORM** First Named Inventor Guillermo J. Tearney Art Unit 3737 (to be used for all correspondence after initial filing) **Examiner Name** To be determined Attorney Docket Number 036140/US - 475387-00020 Total Number of Pages in This Submission

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Page 2 of 6 Form PTO-1449 U.S. Department of Commerce Atty. Docket No. Serial No. (REV. 2-82) Patent and Trademark Office 036140/US - 475387-00020 10/765,430 INFORMATION DISCLOSURE STATEMENT Applicant(s) **BY APPLICANT** Guillermo J. Tearney (Use several sheets if necessary) Filing Date Group January 26, 2004 3737

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